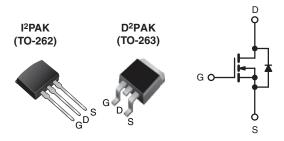


IRFBE30S, IRFBE30L, SiHFBE30S, SiHFBE30L

Vishay Siliconix

Power MOSFET

| PRODUCT SUMMARY | | | | | |
|---------------------------------|------------------------|--------|--|--|--|
| V _{DS} (V) | 80 | 0 | | | |
| $R_{DS(on)}\left(\Omega\right)$ | V _{GS} = 10 V | 3.0 | | | |
| Q _g (Max.) (nC) | 78 | 3 | | | |
| Q _{gs} (nC) | 9.0 | 6 | | | |
| Q _{gd} (nC) | 45 | 5 | | | |
| Configuration | Sing | Single | | | |



N-Channel MOSFET

FEATURES

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

| ORDERING INFORMATION | | | | | |
|----------------------|-----------------------------|-----------------------------|-----------------------------|--|--|
| Package | D ² PAK (TO-263) | D ² PAK (TO-263) | I ² PAK (TO-262) | | |
| Lood (Ph) from | IRFBE30SPbF IRFBE30STRLPbFa | | IRFBE30LPbF | | |
| Lead (Pb)-free | SiHFBE30S-E3 | SiHFBE30STL-E3a | SiHFBE30L-E3 | | |
| SnPb —— | IRFBE30S | - | - | | |
| | SiHFBE30S | - | - | | |

Note

a. See device orientation.

| ABSOLUTE MAXIMUM RATINGS T | _C = 25 °C, ur | nless otherw | ise noted | | | |
|--|--------------------------|-------------------------|-----------------------------------|------------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 800 | V | |
| Gate-Source Voltage | | | V_{GS} | ± 20 | V | |
| Continuous Drain Current | V _{GS} at 10 V | T _C = 25 °C | - I _D | 4.1 | | |
| | V _{GS} at 10 V | T _C = 100 °C | | 2.6 | Α | |
| Pulsed Drain Current ^a | | | I _{DM} | 16 | | |
| Linear Derating Factor | | | | 1.0 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 260 | mJ | |
| Avalanche Current ^a | | | I _{AR} | 4.1 | Α | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 13 | mJ | |
| Maximum Power Dissipation | T _C = 25 °C | | P_{D} | 125 | W | |
| Peak Diode Recovery dV/dtc | | | dV/dt | 2.0 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 150 | • °C | |
| Soldering Recommendations (Peak Temperature) | for 10 s | | | 300 ^d | | |
| Mounting Torque | 6-32 or M3 screw | | | 10 | lbf ⋅ in | |
| | | | | 1.1 | N · m | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 29 mH, R_G = 25 Ω , I_{AS} = 4.1 A (see fig. 12).
- c. $I_{SD} \le 4.1$ A, $dI/dt \le 100$ A/ μ s, $V_{DD} \le 600$ V, $T_{J} \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

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| THERMAL RESISTANCE RATINGS | | | | | | |
|-------------------------------------|-------------------|------|------|------|------|--|
| PARAMETER | SYMBOL | MIN. | TYP. | MAX. | UNIT | |
| Maximum Junction-to-Ambient | R _{thJA} | - | - | 62 | | |
| Case-to-Sink, Flat, Greased Surface | R _{thCS} | - | 0.50 | - | °C/W | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - | - | 1.0 | | |

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

| PARAMETER | SYMBOL | TES | MIN. | TYP. | MAX. | UNIT | |
|---|-----------------------|---|---|------|------|-------|-----|
| Static | | | | L | | 1 | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0 V, I _D = 250 μA | | 800 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference | - | 0.90 | - | V/°C | |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | 2.0 | - | 4.0 | V | |
| Gate-Source Leakage | I _{GSS} | | V _{GS} = ± 20 V | - | - | ± 100 | nA |
| | _ | V _{DS} = 800 V, V _{GS} = 0 V | | - | - | 100 | μΑ |
| Zero Gate Voltage Drain Current | I_{DSS} | V _{DS} = 640 V, V _{GS} = 0 V, T _J = 125 °C | | - | - | 500 | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 2.5 A ^b | - | - | 3.0 | Ω |
| Forward Transconductance | 9 _{fs} | V _{DS} = 100 V, I _D = 2.5 A | | 2.5 | - | - | S |
| Dynamic | | | | ı | | | |
| Input Capacitance | C _{iss} | $V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5 | | - | 1300 | - | |
| Output Capacitance | C _{oss} | | | - | 310 | - | pF |
| Reverse Transfer Capacitance | C _{rss} | | | - | 190 | - | |
| Total Gate Charge | Qg | | | - | - | 78 | |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V | $V_{GS} = 10 \text{ V}$ $I_D = 4.1 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b | | - | 9.6 | nC |
| Gate-Drain Charge | Q_{gd} | 1 | goo ng. o ana ro | - | - | 45 | |
| Turn-On Delay Time | t _{d(on)} | | | - | 12 | - | |
| Rise Time | t _r | V_{DD} = 400 V, I_D = 4.1 A, R_G = 12 Ω , R_D = 95 Ω , see fig. 10 ^b | | - | 33 | - | ns |
| Turn-Off Delay Time | t _{d(off)} | | | - | 82 | - | |
| Fall Time | t _f | | | - | 30 | - | |
| Internal Drain Inductance | L _D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 4.5 | - | nH |
| Internal Source Inductance | L _S | | | - | 7.5 | - | III |
| Drain-Source Body Diode Characteristic | s | · | | | | | |
| Continuous Source-Drain Diode Current | Is | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 4.1 | A |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 16 | |
| Body Diode Voltage | V_{SD} | $T_J = 25 ^{\circ}\text{C}, I_S = 4.1 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$ | | - | - | 1.8 | V |
| Body Diode Reverse Recovery Time | t _{rr} | T _J = 25 °C, I _F = 4.1 A, dl/dt = 100 A/μs ^b | | - | 480 | 720 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 1.8 | 2.7 | nC |
| Forward Turn-On Time | t _{on} | Intrinsic tu | n-on is dominated by L _S and L _D) | | | | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

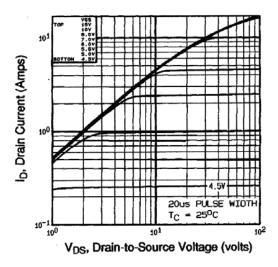


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

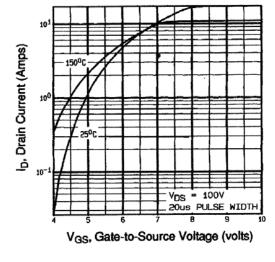


Fig. 3 - Typical Transfer Characteristics

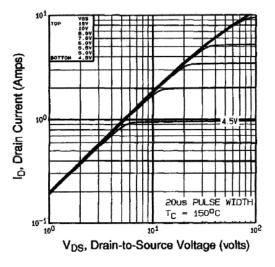


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

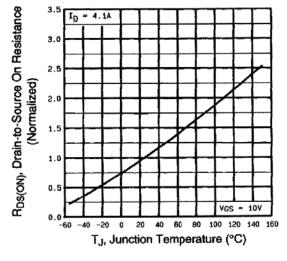


Fig. 4 - Normalized On-Resistance vs. Temperature

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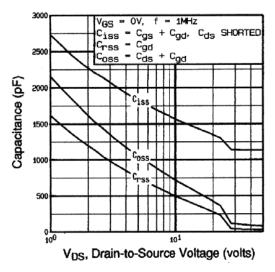


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

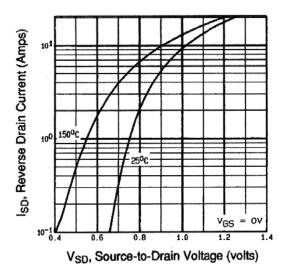


Fig. 7 - Typical Source-Drain Diode Forward Voltage

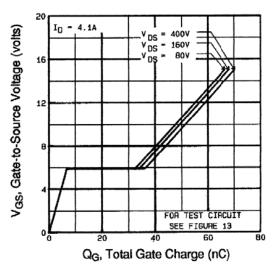


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

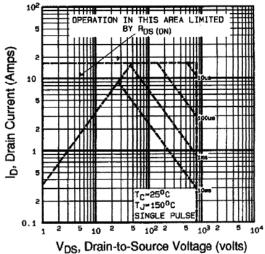


Fig. 8 - Maximum Safe Operating Area

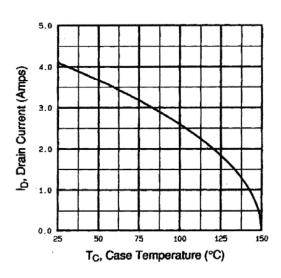


Fig. 9 - Maximum Drain Current vs. Case Temperature

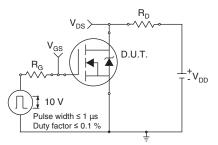


Fig. 10a - Switching Time Test Circuit

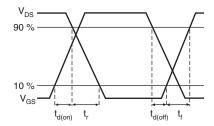


Fig. 10b - Switching Time Waveforms

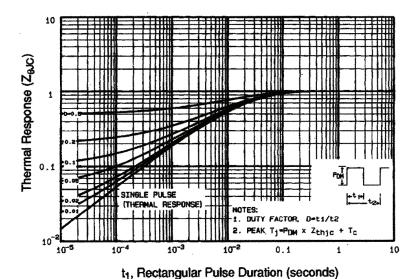


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

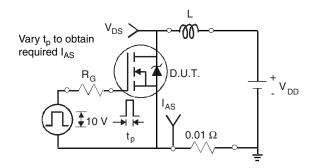


Fig. 12a - Unclamped Inductive Test Circuit

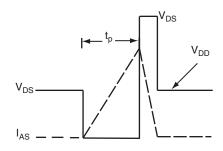


Fig. 12b - Unclamped Inductive Waveforms



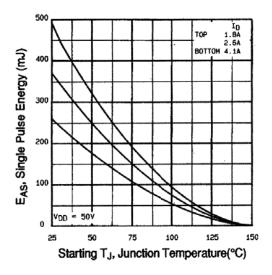


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

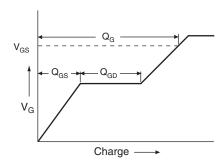


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

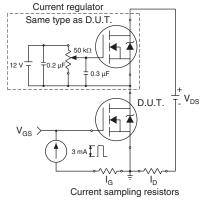
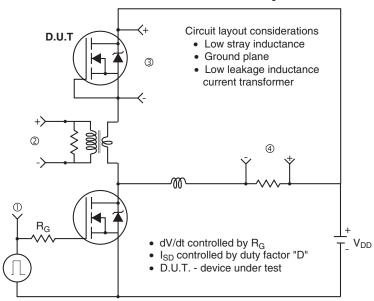
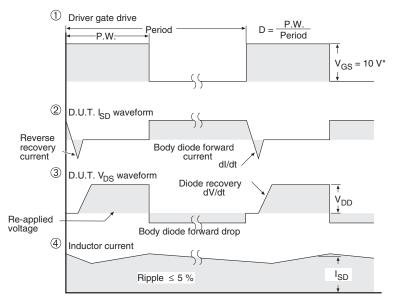


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level and 3 V drive devices

Fig. 14 - For N-Channel

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